











**TPS563231** 

SLUSD65B-JULY 2018-REVISED OCTOBER 2019

# TPS563231 4.5-V to 17-V Input, 3-A Synchronous Step-Down Voltage Regulator in SOT563

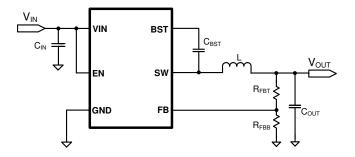
#### **Features**

- 3-A Converter integrated 95-m $\Omega$  and 55-m $\Omega$  FETs
- D-CAP3™ mode control with fast transient response
- Input voltage range: 4.5 V to 17 V
- Output voltage range: 0.6 V to 7 V
- Pulse skip mode
- 600-kHz switching frequency
- Low shutdown current Less than 12 µA
- 2% Feedback voltage accuracy (25°C)
- Startup from pre-biased output voltage
- Cycle-by-cycle over current limit
- Hiccup-mode over current protection
- Non-latch UVP and TSD protections
- 6-Pin SOT563 package

## Applications

- Digital TV power supply
- High definition Blu-ray<sup>™</sup> disc players
- Networking home terminal
- Digital set top box (STB)
- Surveillance

## **Simplified Schematic**



## 3 Description

The TPS563231 is a simple, easy-to-use, synchronous step-down converter in package.

The device is optimized to operate with minimum external component counts and also optimized to achieve low standby current.

These switch mode power supply (SMPS) devices employ D-CAP3 mode control providing a fast transient response and supporting both equivalent series resistance (ESR) output capacitors such as specialty polymer and ultra-low ESR ceramic capacitors with external compensation no components.

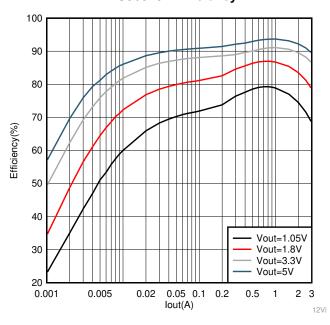
During light load operation, TPS563231 operates in pulse skip mode (PSM), which maintains high efficiency. The TPS563231 is available in a 6-pin 1.6mm x 1.6-mm SOT563 (DRL) package, and specified from a -40°C to 125°C junction temperature.

#### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
TPS563231	DRL (6)	1.60 mm × 1.60 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.

## TPS563231 Efficiency





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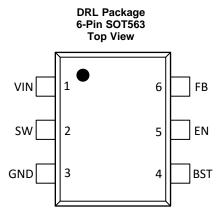
# 4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision A (January 2019) to Revision B	Page
Changed FB I/O Version from 'O' to 'I'	5
Changed Function Block Diagram Pin number	10
Changes from Original (July 2018) to Revision A	Page
Changed marketing status from Advance Information to Final.	1



# **5 Pin Configuration and Functions**



**Pin Functions** 

ı	PIN	I/O			
NAME	AME NO.		DESCRIPTION		
BST	4	0	Supply input for the high-side NFET gate drive circuit. Connect 0.1 µF capacitor between BST and SW pins.		
EN	5	I	Enable input control. High = On, Low = Off. Can be connected to VIN. Do not float. Adjust the input undervoltage lockout with EN resistor divider.		
FB	6	I	Converter feedback input. Connect to output voltage with feedback resistor divider.		
GND	3	_	Power ground terminals, connected to the source of low-side FET internally. Connect to system ground, ground side of $C_{\text{IN}}$ and $C_{\text{OUT}}$ . Path to $C_{\text{IN}}$ must as short as possible.		
SW	2	0	Switch node connection between high-side NFET and low-side NFET.		
VIN	1	I	Input voltage supply pin. The drain terminal of high-side power NFET.		

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## 6 Specifications

## 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

		MIN	MAX	UNIT
	VIN	-0.3	19	V
	BST	-0.3	24.5	V
	BST (10 ns transient)	-0.3	26.5	V
lancet college	BST to SW	-0.3	5.5	V
Input voltage	FB	-0.3	5.5	V
	EN	-0.3	VIN + 0.3	V
	SW	-2	19	V
	SW (10 ns transient)	-3.5	21	V
Operating junction temperature	T <sub>J</sub>	-40	150	°C
Storage temperature	T <sub>stg</sub>	<b>-</b> 55	150	°C

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

## 6.2 ESD Ratings

			VALUE	UNIT
		Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 (1)	±2000	
V <sub>(ESD</sub>	) Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup>	±500	V

<sup>(1)</sup> JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

#### 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	MAX	UNIT
	VIN	4.5	17	V
	BST	-0.1	22	
lancet colleges	BST to SW	-0.1	5	
Input voltage	EN	-0.1	VIN	V
	FB	-0.1	4.5	
	SW	-1.8	17	
Operating junction temperature	T <sub>J</sub>	-40	125	°C

<sup>(2)</sup> JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



# 6.4 Thermal Information

		TPS56323x	
	THERMAL METRIC <sup>(1)</sup>	DRL	UNIT
		6 PINS	
$\theta_{JA}$	Junction-to-ambient thermal resistance	135.8	°C/W
$\theta_{JC(top)}$	Junction-to-case (top) thermal resistance	45.5	°C/W
$\theta_{JB}$	Junction-to-board thermal resistance	23.8	°C/W
ΨЈТ	Junction-to-top characterization parameter	1.2	°C/W
ΨЈВ	Junction-to-board characterization parameter	24.0	°C/W

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.



## 6.5 Electrical Characteristics

 $T_J = -40$ °C to 125°C,  $V_{IN} = 12$  V (unless otherwise noted)

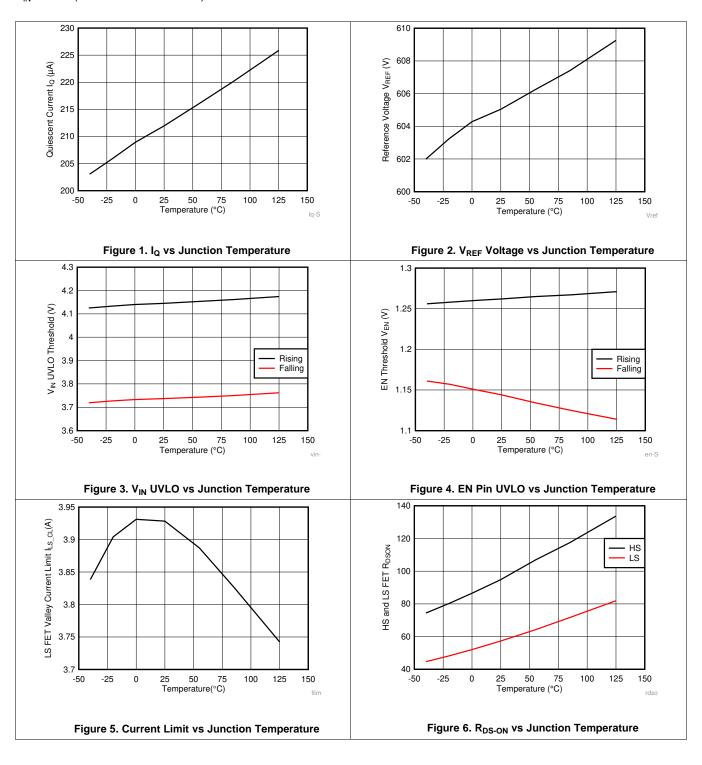
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNI
POWER SUPI	PLY (VIN PIN)		·			
lvin	Operating – non-switching supply current	V <sub>EN</sub> = 5 V, V <sub>FB</sub> = 0.7 V		220	300	μA
VINSDN	Shutdown supply current	$V_{EN} = 0 V$		2	12	μΑ
		Rising threshold		4.0	4.3	
$V_{IN\_UVLO}$	Undervoltage lockout thresholds	Falling threshold	3.3	3.6		V
		Hysteresis		0.4		
ENABLE (EN	PIN)					
$V_{ENH}$	EN high-level input voltage		1.10	1.24	1.42	V
V <sub>ENL</sub>	EN low-level input voltage		1.00	1.13	1.30	V
R <sub>EN</sub>	EN pin resistance to GND	V <sub>EN</sub> = 12 V		1000		kΩ
VOLTAGE RE	FERENCE (FB PIN)					
V	Deference welters	V <sub>IN</sub> = 4.5 V to 17 V, T <sub>J</sub> = 25 °C	588	600	612	m۷
$V_{REF}$	Reference voltage	V <sub>IN</sub> = 4.5 V to 17 V, T <sub>J</sub> = -40°C to 125°C		600		m√
I <sub>FB</sub>	V <sub>FB</sub> input current	V <sub>FB</sub> = 0.6 V		0	±100	nA
MOSFET			·			
R <sub>DSON_H</sub>	High-side switch resistance	$T_J = 25^{\circ}C, V_{BST} - V_{SW} = 5V$		95		mΩ
R <sub>DSON_L</sub>	Low-side switch resistance	T <sub>J</sub> = 25°C		55		mΩ
CURRENT LI	MIT				•	
I <sub>OC_LS</sub>	Low side FET source current limit		3	3.9	4.8	А
I <sub>zc</sub>	Zero cross current detection			0		Α
THERMAL SH	HUTDOWN		·			
<b>-</b>	Thermal shutdown	Shutdown temperature		160		°C
$T_{\sf SDN}$	threshold (1)	Hysteresis		25		٦٠
ON-TIME TIM	ER CONTROL				•	
t <sub>ON(MIN)</sub>	Minimum on time <sup>(1)</sup>			80		ns
t <sub>OFF(MIN)</sub>	Minimum off time <sup>(1)</sup>	V <sub>FB</sub> = 0.5 V		250		ns
SOFT START					•	
Tss	Soft-start time	Internal soft-start time		1.5		ms
FREQUENCY			,			
F <sub>sw</sub>	Switching frequency	V <sub>IN</sub> = 12 V, V <sub>OUT</sub> = 3.3 V, CCM mode		600		kH:
	DERVOLTAGE AND OVERVOL					
V <sub>UVP</sub>	Output UVP falling threshold	Hiccup detect		65		%
T <sub>HICCUP</sub> WAIT	UVP propagation delay	-		0.8		ms
T <sub>HICCUP_RE</sub>	Hiccup time before restart			24		ms

<sup>(1)</sup> Not production tested.



## 6.6 Typical Characteristics

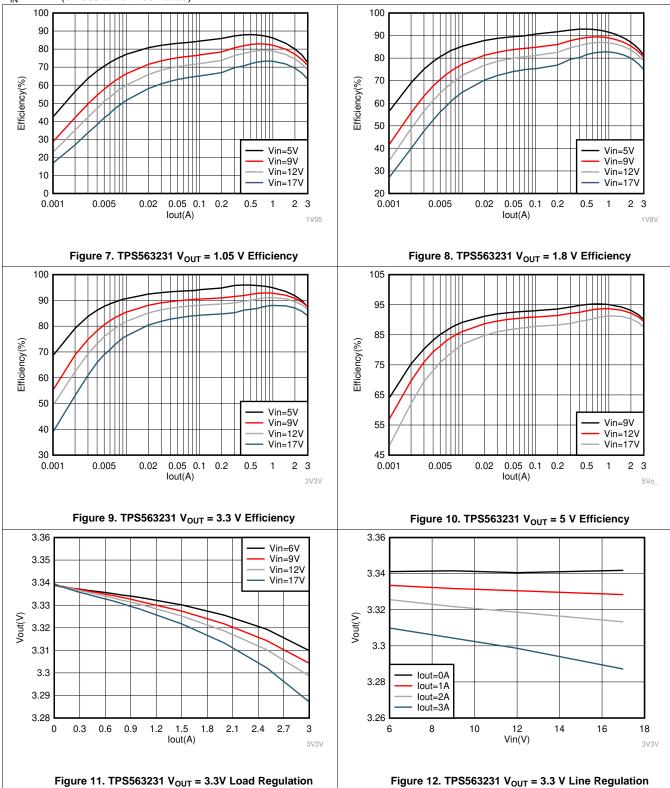
V<sub>IN</sub> = 12 V (unless otherwise noted)





## **Typical Characteristics (continued)**

V<sub>IN</sub> = 12 V (unless otherwise noted)



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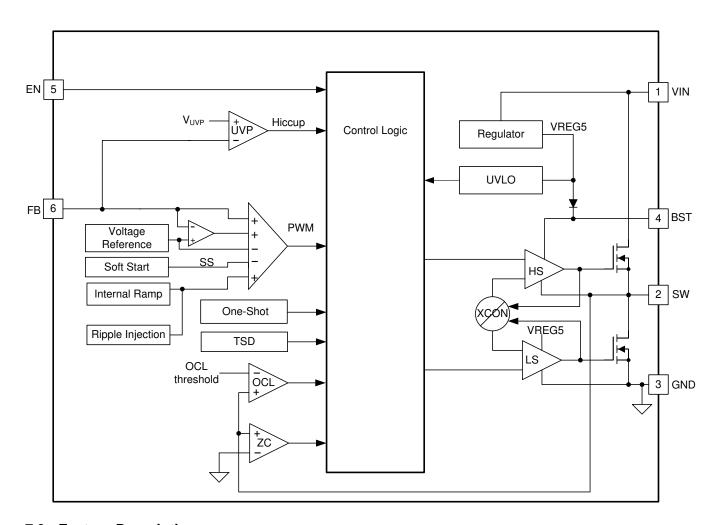


## 7 Detailed Description

#### 7.1 Overview

The TPS563231 is 3-A synchronous step-down converter. The proprietary D-CAP3 mode control supports low ESR output capacitors such as specialty polymer capacitors and multi-layer ceramic capacitors without complex external compensation circuits. The fast transient response of D-CAP3 mode control can reduce the output capacitance required to meet a specific level of performance.

#### 7.2 Functional Block Diagram



#### 7.3 Feature Description

#### 7.3.1 Adaptive On-Time Control and PWM Operation

The main control loop of the TPS563231 is adaptive on-time pulse width modulation (PWM) controller that supports a proprietary D-CAP3 mode control. The D-CAP3 mode control combines adaptive on-time control with an internal compensation circuit for pseudo-fixed frequency and low external component count configuration with both low-ESR and ceramic output capacitors. It is stable even with virtually no ripple at the output.

At the beginning of each cycle, the high-side MOSFET is turned on. This MOSFET is turned off after internal on-shot timer expires. This one shot duration is set proportional to the converter output voltage,  $V_{\text{OUT}}$ , and inversely proportional to the input voltage,  $V_{\text{IN}}$ , to maintain a pseudo-fixed frequency over the input voltage range, hence it is called adaptive on-time control. The on-shot timer is reset and the high-side MOSFET is turned on again when the feedback voltage falls below the reference voltage. An internal ramp is added to reference voltage to simulate output ripple, eliminating the need for ESR induced output ripple from D-CAP3 mode control.

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## **Feature Description (continued)**

#### 7.3.2 Soft Start and Pre-Biased Soft Start

The TPS563231 has an internal 1.5-ms soft-start. When the EN pin becomes high, the internal soft-start function begins ramping up the reference voltage from 0 V to 0.6 V linearly.

If the output capacitor is pre-biased at startup, the devices initiate switching and start ramping up only after the internal reference voltage becomes greater than the feedback voltage  $V_{FB}$ . This scheme ensures that the converters ramp up smoothly into regulation point.

#### 7.3.3 Over Current and Short Circuit Protection

The TPS563231 is protected from over-current conditions by cycle-by-cycle current limit on the valley of the inductor current. Hiccup mode will be activated if a fault condition persists to prevent over-heating.

The current going through low-side (LS) MOSFET is sensed and monitored. When the LS MOSFET turns on, the inductor current begins to ramp down. The LS MOSFET will not be turned OFF if its current is above the LS current limit  $I_{LS\_LIMIT}$  even the feedback voltage,  $V_{FB}$ , drops below the reference voltage  $V_{REF}$ . The LS MOSFET is kept ON so that inductor current keeps ramping down, until the inductor current ramps below the LS current limit  $I_{LS\_LIMIT}$ . Then the LS MOSFET is turned OFF and the HS switch is turned on after a dead time.

As the inductor current is limited by  $I_{LS\_LIMT}$ , the output voltage tends to drop as the inductor current may be smaller than the load current. Hiccup current protection mode is activated once the  $V_{FB}$  drops below the UVP threshold after a delay time (800  $\mu$ s typically). In hiccup mode, the regulator is shut down and kept off for 24 ms typically before the TPS563231 try to start again. If over-current or short-circuit fault condition still exists, hiccup will repeat until the fault condition is removed. Hiccup mode reduces power dissipation under severe over-current conditions, prevents over-heating and potential damage to the device.

#### 7.3.4 Undervoltage Lockout (UVLO) Protection

UVLO protection monitors the internal regulator voltage. When the voltage is lower than UVLO threshold voltage, the device is shut off. This protection is non-latching.

#### 7.3.5 Thermal Shutdown

The device monitors the temperature of itself. If the temperature exceeds the threshold value (typically 160°C), the device is shut off. This is a non-latch protection.

#### 7.4 Device Functional Modes

#### 7.4.1 Shutdown Mode

The EN pin provides electrical ON and OFF control for the TPS563231. When  $V_{EN}$  is below its threshold (1.13 V typically), the device is in shutdown mode. The switching regulator is turned off and the quiescent current drops to 2.0  $\mu$ A typically. The TPS563231 also employs  $V_{IN}$  under voltage lock out protection. If  $V_{IN}$  voltage is below its UVLO threshold (3.6 V typically), the regulator is turned off.

#### 7.4.2 Continuous Conduction Mode (CCM)

Continuous Conduction Mode (CCM) operation is employed when the load current is higher than half of the peak-to-peak inductor current. In CCM operation, the frequency of operation is pseud fixed, output voltage ripple will be at a minimum in this mode and the maximum output current of 3-A can be supplied.



## **Device Functional Modes (continued)**

## 7.4.3 Pulse Skip Mode (PSM, TPS563231)

The TPS563231 is designed with Advanced Eco-mode<sup>™</sup> to maintain high light load efficiency. As the output current decreases from heavy load condition, the inductor current is also reduced and eventually comes to point that its rippled valley touches zero level, which is the boundary between continuous conduction mode (CCM) and discontinuous conduction mode (DCM). The low-side MOSFET is turned off when the zero inductor current is detected. As the load current further decreases the converter runs into discontinuous conduction mode. The ontime is kept almost the same as it was in the continuous conduction mode so that it takes longer time to discharge the output capacitor with smaller load current to the level of the reference voltage. This makes the switching frequency lower, proportional to the load current, and keeps the light load efficiency high. The transition point to the light load operation current I<sub>OUT LL</sub> can be calculated in Equation 1.

$$I_{OUT\_LL} = \frac{1}{2 \times L \times f_{SW}} \times \frac{(V_{IN} - V_{OUT}) \times V_{OUT}}{V_{IN}}$$
(1)

As the load current continues to decrease, the switching frequency also decreases. The on-time starts to decrease once the switching frequency is lower than 250 kHz. The on-time can be about 22% reduced at most for extremely light load condition. This function is employed to achieve smaller ripple at extremely light load condition.

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## 8 Application and Implementation

#### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

## 8.1 Application Information

The device is typical step-down DC-DC converter. It is typically used to convert a higher dc voltage to a lower dc voltage with a maximum available output current of 3 A. The following design procedure can be used to select component values for the TPS563231. Alternately, the WEBENCH® software may be used to generate a complete design. The WEBENCH software uses an iterative design procedure and accesses a comprehensive database of components when generating a design. This section presents a simplified discussion of the design process.

#### 8.2 Typical Application

The TPS563231 only requires a few external components to convert from a higher variable voltage supply to a fixed output voltage. Figure 13 shows a basic schematic of 3.3-V output application. This section provides the design procedure.

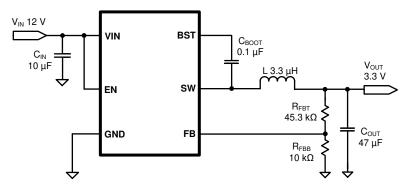


Figure 13. TPS563231 3.3V/3-A Reference Design

#### 8.2.1 Design Requirements

Table 1 shows the design parameters for this application.

**Table 1. Design Parameters** 

PARAMETER	EXAMPLE VALUE
Input voltage range	4.5 to 17 V
Output voltage	3.3 V
Transient response, 3-A load step	$\Delta$ Vout = ±5%
Input ripple voltage	400 mV
Output ripple voltage	30 mV
Output current rating	3 A
Operating frequency	600 kHz

#### 8.2.2 Detailed Design Procedure

#### 8.2.2.1 Output Voltage Resistors Selection

The output voltage is set with a resistor divider from the output node to the FB pin. 1% tolerance or better divider resistors are recommended. Start by using Equation 2 to calculate  $V_{OUT}$ .



To improve efficiency at very light loads consider using larger value resistors, too high of resistance will be more susceptible to noise and voltage errors from the FB input current will be more noticeable.

$$V_{OUT} = 0.6 \times \left(1 + \frac{R_{FBT}}{R_{FBB}}\right)$$
 (2)

Choose the value of  $R_{FBB}$  to be 10 k $\Omega$ . With the desired output voltage set to 3.3 V and the  $V_{REF}$  = 0.6 V, the  $R_{FBT}$  value can then be calculated using Equation 2. The formula yields to a value 45.3 k $\Omega$  of  $R_{FBT}$ .

#### 8.2.2.2 Output Filter Selection

The LC filter used as the output filter has double pole at:

$$f_{P} = \frac{1}{2\pi\sqrt{L \times C_{OUT}}}$$
(3)

At low frequencies, the overall loop gain is set by the output set-point resistor divider network and the internal gain of the device. The low frequency phase is 180°. At the output filter pole frequency, the gain rolls off at a –40 dB per decade rate and the phase drops rapidly. D-CAP3 introduces a high frequency zero that reduces the gain roll off to –20 dB per decade and increases the phase to 90° one decade above the zero frequency. The inductor and capacitor for the output filter must be selected so that the double pole of Equation 3 is located below the high frequency zero but close enough that the phase boost provided be the high frequency zero provides adequate phase margin for a stable circuit. To meet this requirement use the values recommended in Table 2.

**Table 2. Recommended Component Values** 

OUTPUT	P1 (kg)	P2 (kO)	L1 (μH)			C9 . C0 (uE)
VOLTAGE (V)	R1 (kΩ)	R2 (kΩ)	MIN TYP MA		MAX	C8 + C9 (µF)
1	6.65	10.0	1	1.2	4.7	20 to 68
1.05	7.5	10.0	1	1.2	4.7	20 to 68
1.2	10	10.0	1.2	1.5	4.7	20 to 68
1.5	15	10.0	1.5	1.5	4.7	20 to 68
1.8	20	10.0	1.5	2.2	4.7	20 to 68
2.5	31.6	10.0	2.2	2.2	4.7	20 to 68
3.3	45.3	10.0	2.2	3.3	4.7	20 to 68
5	73.2	10.0	3.3	4.7	4.7	20 to 68
6.5	97.6	10.0	3.3	4.7	4.7	20 to 68

The inductor peak-to-peak ripple current, peak current and RMS current are calculated using Equation 4, Equation 5, and Equation 6. The inductor saturation current rating must be greater than the calculated peak current and the RMS or heating current rating must be greater than the calculated RMS current.

$$I_{L\_PP} = \frac{V_{OUT}}{V_{IN\_MAX}} \times \frac{V_{IN\_MAX} - V_{OUT}}{L \times f_{SW}}$$
(4)

$$I_{L_{PK}} = I_{OUT} + \frac{I_{L_{PP}}}{2}$$
(5)

$$I_{L\_RMS} = \sqrt{I_{OUT}^2 + \frac{1}{12}I_{L\_PP}^2}$$
 (6)

For this design example, the calculated peak current is 3.67 A and the calculated RMS current is 3.02 A. The inductor used is a WE 74437349033 with a peak current rating of 12 A and an RMS current rating of 6 A.

The capacitor value and ESR determine the amount of output voltage ripple. The TPS563231 is intended for use with ceramic or other low ESR capacitors. Recommended values range from 20  $\mu$ F to 68  $\mu$ F. Use Equation 7 to determine the required RMS current rating for the output capacitor.

$$I_{C\_RMS} = \frac{V_{OUT} \times (V_{IN\_MAX} - V_{OUT})}{\sqrt{12} \times V_{IN\_MAX} \times L \times f_{SW}}$$
(7)

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For this design two Murata GRM21BR61A226ME44L 22- $\mu$ F/10-V output capacitors are used in parallel. The typical ESR is  $3m\Omega$  each. The calculated RMS current is 0.39 A and each output capacitor is rated for 5 A.

#### 8.2.2.3 Input Capacitor Selection

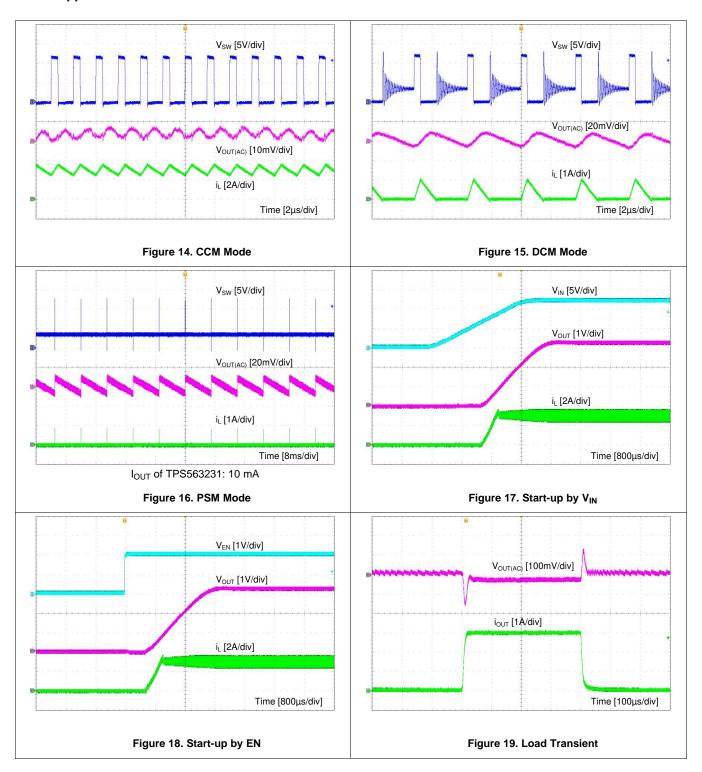
The TPS563231 requires an input decoupling capacitor and a bulk capacitor is needed depending on the application. TI recommends a ceramic capacitor over 10-µF for the decoupling capacitor. An additional 0.1-µF capacitor from VIN pin to GND pin is also recommended to provide additional high frequency filtering. The capacitor voltage rating needs to be greater than the maximum input voltage, 25 V or higher voltage rating is recommended.

#### 8.2.2.4 Bootstrap Capacitor Selection

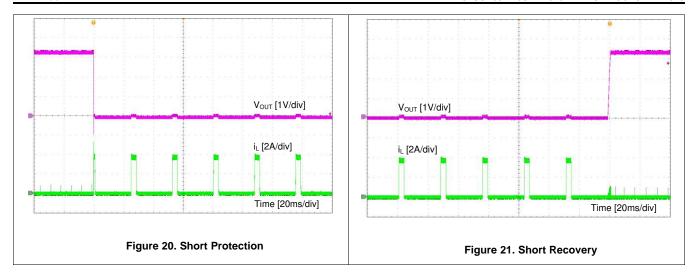
A 0.1-µF ceramic capacitor must be connected between the BST to SW pin for proper operation. 10 V or higher voltage rating is recommended.

# TEXAS INSTRUMENTS

## 8.2.3 Application Curves







# 9 Power Supply Recommendations

TPS563231 is designed to operate from input supply voltage in the range of 4.5 V to 17 V. Buck converters require the input voltage to be higher than the output voltage for proper operation. The maximum recommended operating duty cycle is 72%. Using that criteria, the minimum recommended input voltage is  $V_{\rm O}$  / 0.72.

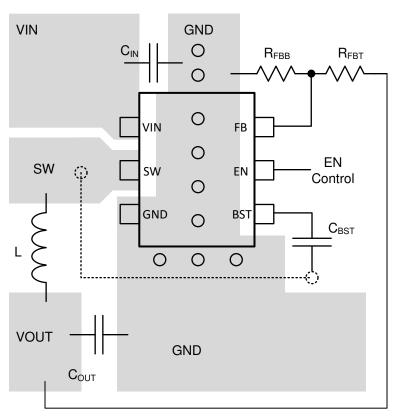


## 10 Layout

#### 10.1 Layout Guidelines

- 1. VIN and GND traces should be as wide as possible to reduce trace impedance. The wide areas are also of advantage from the view point of heat dissipation.
- 2. The input capacitor and output capacitor should be placed as close to the device as possible to minimize trace impedance.
- 3. Provide sufficient vias for the input capacitor and output capacitor.
- 4. Keep the SW trace as physically short and wide as practical to minimize radiated emissions.
- 5. Do not allow switching current to flow under the device.
- 6. A separate VOUT path should be connected to the upper feedback resistor.
- 7. Make a Kelvin connection to the GND pin for the feedback path.
- 8. Voltage feedback loop should be placed away from the high-voltage switching trace, and preferably has ground shield.
- 9. The trace of the VFB node should be as small as possible to avoid noise coupling.
- 10. The GND trace between the output capacitor and the GND pin should be as wide as possible to minimize its trace impedance.

## 10.2 Layout Example



- VIA (Connected to GND plane at bottom layer)
- VIA (Connected to SW)

Figure 22. TPS563231 Layout

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## 11 Device and Documentation Support

#### 11.1 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to order now.

Table 3. Related Links

PARTS	PRODUCT FOLDER	R ORDER NOW TECHNICAL TOOLS & SOFTWARE CO		1 - 3 - 3 - 3 - 3 - 3 - 3 - 3 - 3 - 3 -	
TPS563231	Click here	Click here	Click here	Click here	Click here

## 11.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### 11.3 Community Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

#### 11.4 Trademarks

D-CAP3, E2E are trademarks of Texas Instruments. WEBENCH is a registered trademark of Texas Instruments. Blu-ray is a trademark of Blu-ray Disc Association.

#### 11.5 Electrostatic Discharge Caution

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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 11.6 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

## 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



## PACKAGE OPTION ADDENDUM

10-Dec-2020

#### **PACKAGING INFORMATION**

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Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
TPS563231DRLR	ACTIVE	SOT-5X3	DRL	6	4000	RoHS & Green	Call TI   SN	Level-1-260C-UNLIM	-40 to 125	3231	Samples
TPS563231DRLT	ACTIVE	SOT-5X3	DRL	6	250	RoHS & Green	Call TI   SN	Level-1-260C-UNLIM	-40 to 125	3231	Samples

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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10-Dec-2020



PLASTIC SMALL OUTLINE



## NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing
- per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
  4. Reference JEDEC registration MO-293 Variation UAAD



PLASTIC SMALL OUTLINE



NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.7. Land pattern design aligns to IPC-610, Bottom Termination Component (BTC) solder joint inspection criteria.



PLASTIC SMALL OUTLINE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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